

Notic of Referenc s Cited

Application/Control No.		Applicant(s)/Patent Under R examination SUN ET AL.		
Examiner	一	Art Unit		
David V. Chung		2871	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,480,285	11-2002	Hill, Henry A.	356/492
	В	US-5,414,547	05-1995	Matsuo et al.	349/44
	С	US-4,572,616	02-1986	Kowel et al.	349/200
	D	US-6,388,809	05-2002	MacAulay, Calum E.	359/383
	Е	US-4,333,720	06-1982	Suzuki et al.	396/506
	F	US-6,549,730	04-2003	Hamada, Masataka	396/111
	G	US-4,313,633	02-1982	Muntjanoff et al.	294/88
	Н	US-6,191,881	02-2001	Tajima, Eiichi	359/254
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	>	·
	8	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.